

<b>Notice of References Cited</b>	Application/Control No. 10/695,271	Applicant(s)/Patent Under Reexamination GEDEBOU, TEWODROS	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,648,903	11-2003	Pierson, III, Raymond H.	606/232
	B	US-6,447,516	09-2002	Bonutti, Peter M.	606/72
	C	US-5,782,862	07-1998	Bonutti, Peter M.	606/232
	D	US-5,522,844	06-1996	Johnson, Lanny L.	606/232
	E	US-4,898,156	02-1990	Gatturna et al.	606/72
	F	US-5,403,348	04-1995	Bonutti, Peter M.	606/232
	G	US-5,041,129	08-1991	Hayhurst et al.	606/232
	H	US-5,681,352	10-1997	Clancy et al.	606/232
	I	US-4,741,330	05-1988	Hayhurst, John O.	606/144
	J	US-5,814,072	09-1998	Bonutti, Peter M.	606/232
	K	US-6,328,758	12-2001	Tornier et al.	606/232
	L	US-6,616,694	09-2003	Hart, Rickey D.	623/13.14
	M	US-6,200,329	03-2001	Fung et al.	606/232

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 00/13601	03-2000	WIPO	Pierson	606/232
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,086,608	07-2000	Ek et al.	606/232
	B	US-6,843,799	01-2005	Bartlett, Edwin C.	606/232
	C	US-6,562,071	05-2003	Jarvinen, Teppo	623/13.14
	D	US-6,855,157	02-2005	Foerster et al.	606/232
	E	US-6,685,728	02-2004	Sinnott et al.	606/232
	F	US-6,660,023	12-2003	McDevitt et al.	606/232
	G	US-6,616,694	09-2003	Hart, Rickey D.	623/13.14
	H	US-5,902,321	05-1999	Caspari et al.	606/232
	I	US-6,027,523	02-2000	Schmieding, Reinhold	606/232
	J	US-2003/0105524	06-2003	Paulos et al.	623/13.14
	K	US-5,964,764	10-1999	West et al.	606/72
	L	US-6,645,227	11-2003	Fallin et al.	606/232
	M	US-5,868,789	02-1999	Huebner, Randall J.	606/232

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,643,320	07-1997	Lower et al.	606/232
	B	US-4,573,844	03-1986	Smith, Gareth J.	411/340
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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